

Low Input Current Logic Gate Optocouplers

Technical Data

HCPL-2200 HCPL-2219

Features

- 2.5 kV/μs Minimum Common Mode Rejection (CMR) at $V_{CM} = 400$ V (HCPL-2219)
- Compatible with LSTTL, TTL, and CMOS Logic
- Wide V_{CC} Range (4.5 to 20 V)
- 2.5 Mbd Guaranteed over Temperature
- Low Input Current (1.6 mA)
- Three State Output (No Pullup Resistor Required)
- Guaranteed Performance from 0°C to 85°C
- Hysteresis
- Safety Approval
UL Recognized -2500 V rms for 1 minute
CSA Approved
VDE 0884 Approved with $V_{IORM} = 630$ V peak (HCPL-2219 Option 060 Only)
- MIL-STD-1772 Version Available (HCPL-5200/1)

Applications

- Isolation of High Speed Logic Systems
- Computer-Peripheral Interfaces
- Microprocessor System Interfaces

- Ground Loop Elimination
- Pulse Transformer Replacement
- Isolated Buss Driver
- High Speed Line Receiver

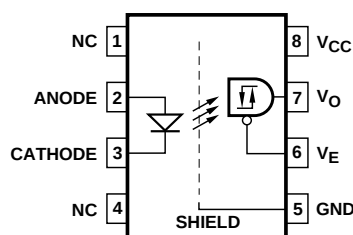
Description

The HCPL-2200/2219 are optically coupled logic gates that combine a GaAsP LED and an integrated high gain photo detector. The detector has a three state output stage and has a

detector threshold with hysteresis. The three state output eliminates the need for a pullup resistor and allows for direct drive of data busses. The hysteresis provides differential mode noise immunity and eliminates the potential for output signal chatter.

A superior internal shield on the HCPL-2219 guarantees common mode transient immunity of 2.5 kV/μs at a common mode voltage of 400 volts.

Functional Diagram



TRUTH TABLE
(POSITIVE LOGIC)

LED	ENABLE	OUTPUT
ON	H	Z
OFF	H	Z
ON	L	H
OFF	L	L

A 0.1 μF bypass capacitor must be connected between pins 5 and 8.

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

The Electrical and Switching Characteristics of the HCPL-2200/2219 are guaranteed over the temperature range of 0°C to 85°C and a V_{CC} range of 4.5 volts to 20 volts. Low I_F and wide V_{CC} range allow compatibility with

TTL, LSTTL, and CMOS logic and result in lower power consumption compared to other high speed optocouplers. Logic signals are transmitted with a typical propagation delay of 160 nsec.

The HCPL-2200/2219 are useful for isolating high speed logic interfaces, buffering of input and output lines, and implementing isolated line receivers in high noise environments.

Selection Guide

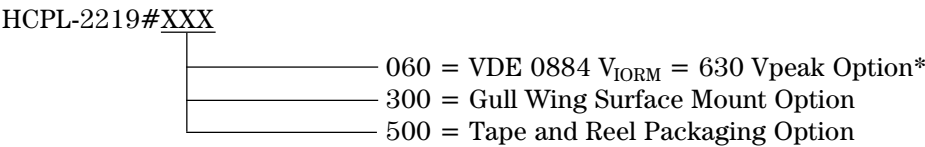
Minimum CMR		Input On-Current (mA)	8-Pin DIP (300 Mil)		Small-Outline SO-8	Widebody (400 Mil)	Hermetic
dV/dt (V/μs)	V _{CM} (V)		Single Channel Package	Dual Channel Package	Single Channel Package	Single Channel Package	Single and Dual Channel Packages
1,000	50	1.6	HCPL-2200 ^[1] HCPL-2201 HCPL-2202		HCPL-0201	HCNW2201	
		1.8		HCPL-2231			
2,500	400	1.6	HCPL-2219 ^[1]				
5,000 ^[2]	300 ^[2]	1.6	HCPL-2211 HCPL-2212		HCPL-0211	HCNW2211	
		1.8		HCPL-2232			
1,000	50	2.0					HCPL-52XX HCPL-62XX

- Notes:**
1. HCPL-2200/2219 devices include output enable/disable functionality.
 2. Minimum CMR of 10 kV/μs with V_{CM} = 1000 V can be achieved with input current, I_F, of 5 mA.

Ordering Information

Specify Part Number followed by Option Number (if desired).

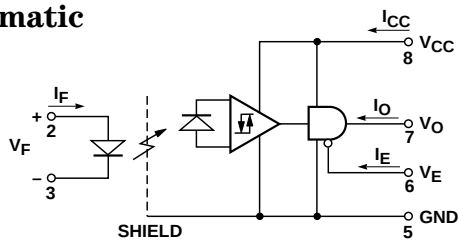
Example:



Option data sheets available. Contact your Hewlett-Packard sales representative or authorized distributor for information.

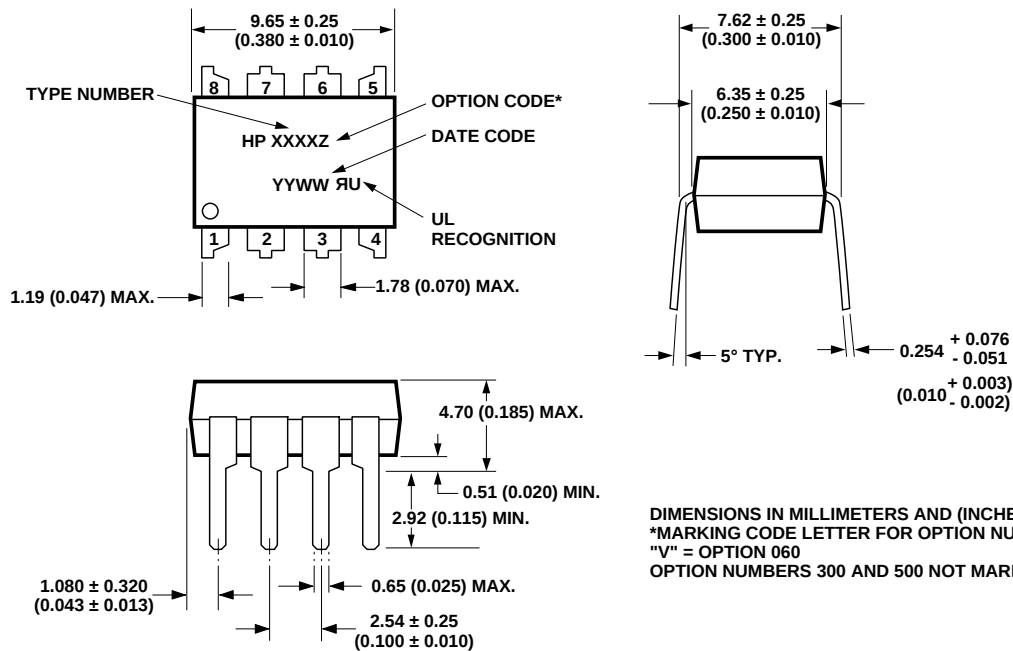
*For HCPL-2219 only.

Schematic

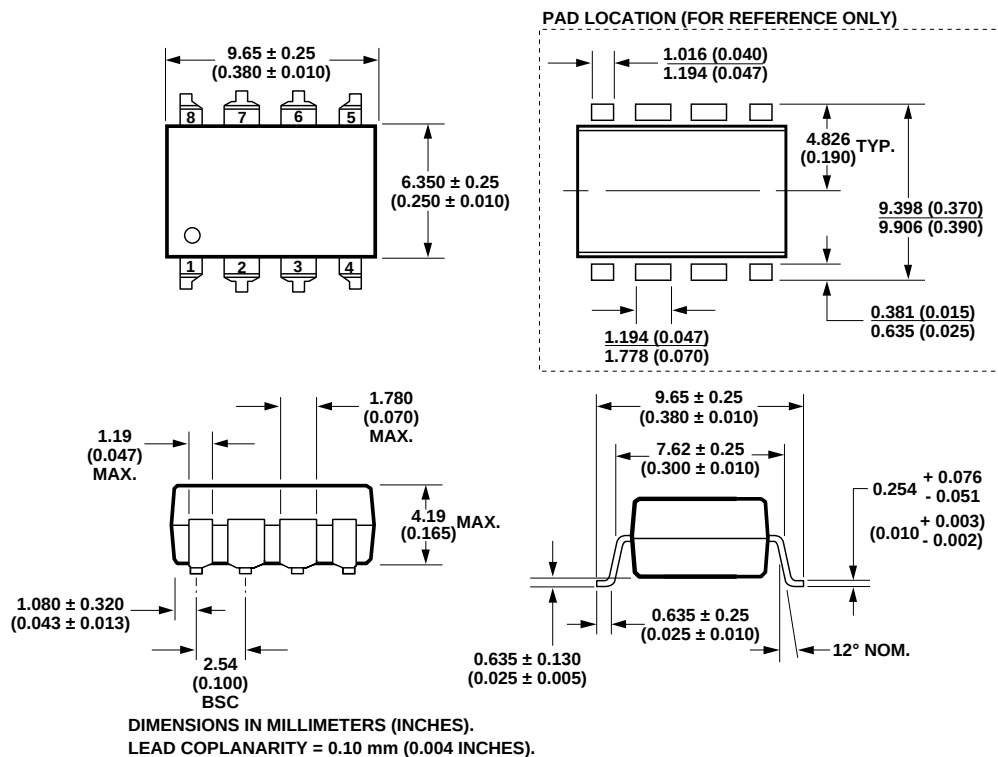


Package Outline Drawings

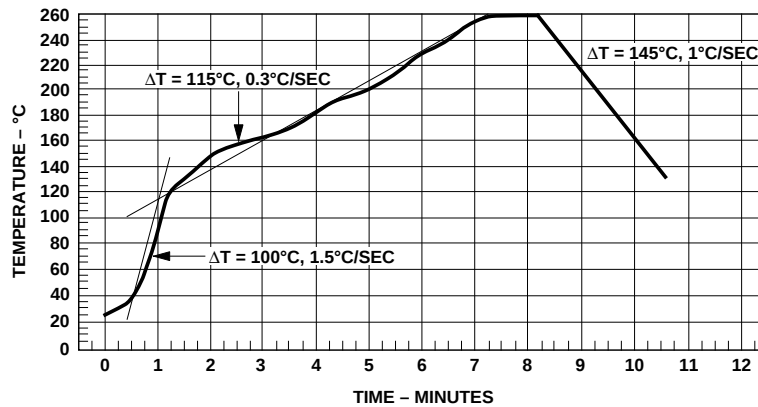
8-Pin DIP Package



8-Pin DIP Package with Gull Wing Surface Mount Option 300



Maximum Solder Reflow Thermal Profile



Note: Use of nonchlorine activated fluxes is highly recommended.

Regulatory Information

The HCPL-2200/2219 have been approved by the following organizations:

CSA

Approved under CSA Component Acceptance Notice #5, File CA 88324.

UL

Recognized under UL 1577, Component Recognition Program, File E55361.

VDE

Approved according to VDE 0884/06.92. (HCPL-2219 Option 060 Only)

Insulation and Safety Related Specifications

Parameter	Symbol	Value	Units	Conditions
Min. External Air Gap (External Clearance)	L(IO1)	7.1	mm	Measured from input terminals to output terminals, shortest distance through air.
Min. External Tracking Path (External Creepage)	L(IO2)	7.4	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	mm	Through insulation distance, conductor to conductor, usually the direct distance between the photoemitter and photodetector inside the optocoupler cavity.
Tracking Resistance (Comparative Tracking Index)	CTI	200	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIIa		Material Group (DIN VDE 0110, 1/89, Table 1)

Option 300 - surface mount classification is Class A in accordance with CECC 00802.

VDE 0884 Insulation Related Characteristics (HCPL-2219 OPTION 060 ONLY)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 300 V rms for rated mains voltage ≤ 450 V rms		I-IV	
		I-III	
Climatic Classification		55/85/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	630	V peak
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	1181	V peak
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	945	V peak
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	6000	V peak
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 12, Thermal Derating curve.) Case Temperature Input Current Output Power	T_S $I_{S,INPUT}$ $P_{S,OUTPUT}$	175 230 600	$^{\circ}\text{C}$ mA mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, (VDE 0884), for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute Maximum Ratings

(No Derating Required up to 70°C)

Parameter	Symbol	Min.	Max.	Units	Note
Storage Temperature	T _S	-55	125	°C	
Operating Temperature	T _A	-40	85	°C	1
Average Forward Input Current	I _{F(AVG)}		10	mA	
Peak Transient Input Current (≤ 1 μs Pulse Width, 300 pps)	I _{F(TRAN)}		1.0	A	
Reverse Input Voltage	V _R		5	V	
Average Output Current	I _O		25	mA	
Supply Voltage	V _{CC}	0	20	V	
Three State Enable Voltage	V _E	-0.5	20	V	
Output Voltage	V _O	-0.5	20	V	
Total Package Power Dissipation	P _T		210	mW	1
Lead Solder Temperature	260°C for 10 sec., 1.6 mm below seating plane				
Solder Reflow Temperature Profile	See Package Outline Drawings section				

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units
Power Supply Voltage	V _{CC}	4.5	20	V
Enable Voltage High	V _{EH}	2.0	20	V
Enable Voltage Low	V _{EL}	0	0.8	V
Forward Input Current	I _{F(ON)}	1.6*	5	mA
Forward Input Current	I _{F(OFF)}	–	0.1	mA
Operating Temperature	T _A	0	85 ^[1]	°C
Fan Out	N		4	TTL Loads

*The initial switching threshold is 1.6 mA or less. It is recommended that 2.2 mA be used to permit at least a 20% CTR degradation guardband.

Electrical Specifications

For $0^{\circ}\text{C} \leq T_A^{[1]} \leq 85^{\circ}\text{C}$, $4.5\text{ V} \leq V_{CC} \leq 20\text{ V}$, $1.6\text{ mA} \leq I_{F(\text{ON})} \leq 5\text{ mA}$, $2.0\text{ V} \leq V_{EH} \leq 20\text{ V}$, $0.0\text{ V} \leq V_{EL} \leq 0.8\text{ V}$, $0\text{ mA} \leq I_{F(\text{OFF})} \leq 0.1\text{ mA}$. All Typical at $T_A = 25^{\circ}\text{C}$, $V_{CC} = 5\text{ V}$, $I_{F(\text{ON})} = 3\text{ mA}$ unless otherwise specified. See Note 7.

Parameter	Sym.	Min.	Typ.	Max.	Units	Test Conditions		Fig.	Note
Logic Low Output Voltage	V_{OL}			0.5	V	$I_{OL} = 6.4\text{ mA}$ (4 TTL Loads)		1	
Logic High Output Voltage	V_{OH}	2.4	*		V	$I_{OH} = -2.6\text{ mA}$ * $V_{OH} = V_{CC} - 2.1\text{ V}$		2	
Output Leakage Current ($V_{OUT} > V_{CC}$)	I_{OHH}			100	μA	$V_O = 5.5\text{ V}$	$I_F = 5\text{ mA}$		
				500	μA	$V_O = 20\text{ V}$	$V_{CC} = 4.5\text{ V}$		
Logic High Enable Voltage	V_{EH}	2.0			V				
Logic Low Enable Voltage	V_{EL}			0.8	V				
Logic High Enable Current	I_{EH}			20	μA	$V_{EN} = 2.7\text{ V}$			
				100	μA	$V_{EN} = 5.5\text{ V}$			
			0.004	250	μA	$V_{EN} = 20\text{ V}$			
Logic Low Enable Current	I_{EL}			-0.32	mA	$V_{EN} = 0.4\text{ V}$			
Logic Low Supply Current	I_{CCL}		4.5	6.0	mA	$V_{CC} = 5.5\text{ V}$	$I_F = 0\text{ mA}$ $I_O = \text{Open}$ $V_E = \text{Don't Care}$		
			5.25	7.5	mA	$V_{CC} = 20\text{ V}$			
Logic High Supply Current	I_{CCH}		2.7	4.5	mA	$V_{CC} = 5.5\text{ V}$	$I_F = 5\text{ mA}$ $I_O = \text{Open}$ $V_E = \text{Don't Care}$		
			3.1	6.0	mA	$V_{CC} = 20\text{ V}$			
High Impedance State Output Current	I_{OZL}			-20	μA	$V_O = 0.4\text{ V}$	$V_{EN} = 2\text{ V}$, $I_F = 5\text{ mA}$		
				20	μA	$V_O = 2.4\text{ V}$	$V_{EN} = 2\text{ V}$, $I_F = 5\text{ mA}$		
				100	μA	$V_O = 5.5\text{ V}$			
				500	μA	$V_O = 20\text{ V}$			
Logic Low Short Circuit Output Current	I_{OSL}	25			mA	$V_O = V_{CC} = 5.5\text{ V}$	$I_F = 0\text{ mA}$		2
		40			mA	$V_O = V_{CC} = 20\text{ V}$			
Logic High Short Circuit Output Current	I_{OSH}	-10			mA	$V_{CC} = 5.5\text{ V}$	$I_F = 5\text{ mA}$, $V_O = \text{GND}$		2
		-25			mA	$V_{CC} = 20\text{ V}$			
Input Current Hysteresis	I_{HYS}		0.12		mA	$V_{CC} = 5\text{ V}$		3	
Input Forward Voltage	V_F		1.5	1.7	V	$T_A = 25^{\circ}\text{C}$	$I_F = 5\text{ mA}$	4	
				1.75					
Input Reverse Breakdown Voltage	BV_R	5			V	$I_R = 10\text{ }\mu\text{A}$			
Input Diode Temperature Coefficient	$\frac{\Delta V_F}{\Delta T_A}$		-1.7		mV/ $^{\circ}\text{C}$	$I_F = 5\text{ mA}$			
Input Capacitance	C_{IN}		60		pF	$f = 1\text{ MHz}$, $V_F = 0\text{ V}$, Pins 2 and 3			

Switching Specifications (AC)

For $0^{\circ}\text{C} \leq T_A^{[1]} \leq 85^{\circ}\text{C}$, $4.5\text{ V} \leq V_{CC} \leq 20\text{ V}$, $1.6\text{ mA} \leq I_{F(ON)} \leq 5\text{ mA}$, $0.0\text{ mA} \leq I_{F(OFF)} \leq 0.1\text{ mA}$.
All Typicals at $T_A = 25^{\circ}\text{C}$, $V_{CC} = 5\text{ V}$, $I_{F(ON)} = 3\text{ mA}$ unless otherwise specified.

Parameter	Sym.	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Logic Low Output Level	t_{PHL}		210		ns	Without Peaking Capacitor	5, 6	4, 5
			160	300		With Peaking Capacitor		
Propagation Delay Time to Logic High Output Level	t_{PLH}		170		ns	Without Peaking Capacitor	5, 6	4, 5
			115	300		With Peaking Capacitor		
Output Enable Time to Logic High	t_{PZH}		25		ns		7, 9	
Output Enable Time to Logic Low	t_{PZL}		28		ns		7, 8	
Output Disable Time from Logic High	t_{PHZ}		105		ns		7, 9	
Output Disable Time from Logic Low	t_{PLZ}		60		ns		7, 8	
Output Rise Time (10-90%)	t_r		55		ns		5, 10	
Output Fall Time (90-10%)	t_f		15		ns		5, 10	

Parameter	Sym.	Device	Min.	Units	Test Conditions		Fig.	Note
Logic High Common Mode Transient Immunity	$ CM_H $	HCPL-2200	1,000	V/ μ s	$ V_{CM} = 50\text{ V}$	$I_F = 1.6\text{ mA}$ $V_{CC} = 5\text{ V}$ $T_A = 25^{\circ}\text{C}$	11	6
		HCPL-2219	2,500	V/ μ s	$ V_{CM} = 400\text{ V}$			
Logic Low Common Mode Transient Immunity	$ CM_L $	HCPL-2200	1,000	V/ μ s	$ V_{CM} = 50\text{ V}$	$V_F = 0\text{ V}$ $V_{CC} = 5\text{ V}$ $T_A = 25^{\circ}\text{C}$	11	6
		HCPL-2219	2,500	V/ μ s	$ V_{CM} = 400\text{ V}$			

Package Characteristics

Parameter	Sym.	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage*	V_{ISO}	2500			V rms	$RH \leq 50\%$, $t = 1\text{ min.}$, $T_A = 25^{\circ}\text{C}$		3, 8
Input-Output Resistance	R_{I-O}		10^{12}		Ω	$V_{I-O} = 500\text{ VDC}$		3
Input-Output Capacitance	C_{I-O}		0.6		pF	$f = 1\text{ MHz}$, $V_{I-O} = 0\text{ VDC}$		3

*The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the VDE 0884 Insulation Characteristics Table (if applicable), your equipment level safety specification or HP Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage," publication number 5963-2203E.

Notes:

1. Derate total package power dissipation, P_T , linearly above 70°C free air temperature at a rate of 4.5 mW/°C.
2. Duration of output short circuit time should not exceed 10 ms.
3. Device considered a two-terminal device: pins 1, 2, 3, and 4 shorted together and pins 5, 6, 7, and 8 shorted together.
4. The t_{PLH} propagation delay is measured from the 50% point on the leading edge of the input pulse to the 1.3 V point on the leading edge of the

output pulse. The t_{PHL} propagation delay is measured from the 50% point on the trailing edge of the input pulse to the 1.3 V point on the trailing edge of the output pulse.

5. When the peaking capacitor is omitted, propagation delay times may increase by 100 ns.
6. CM_L is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_O < 0.8$ V). CM_H is the maximum rate of fall of the common mode voltage that can be

sustained with the output voltage in the logic high state ($V_O > 2.0$ V).

7. Use of a 0.1 μ F bypass capacitor connected between pins 5 and 8 is recommended.
8. In accordance with UL1577, each optocoupler is proof tested by applying an insulation test voltage ≥ 3000 V rms for one second (leakage detection current limit, $I_{L-O} \leq 5$ μ A). This test is performed before the 100% production test for partial discharge (Method b) shown in the VDE 0884 Insulation Characteristics Table, if applicable.

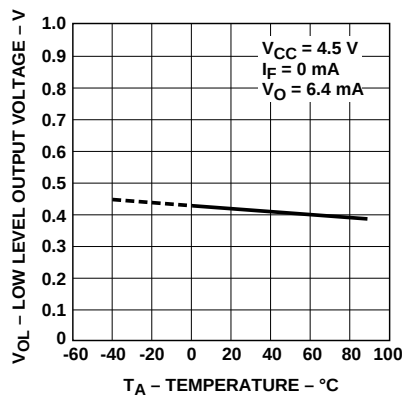


Figure 1. Typical Logic Low Output Voltage vs. Temperature.

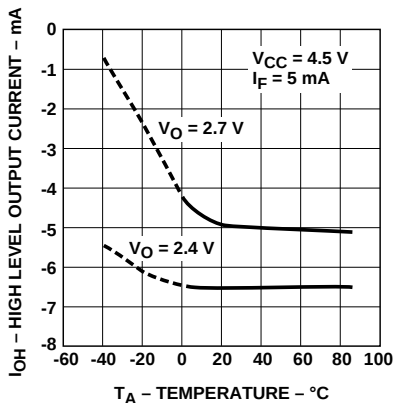


Figure 2. Typical Logic High Output Current vs. Temperature.

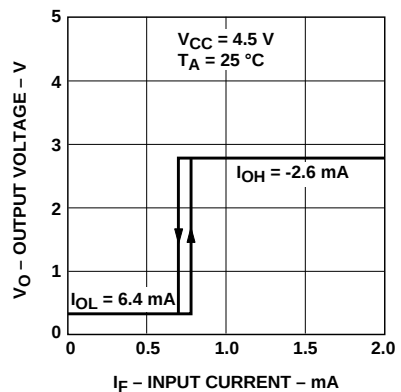


Figure 3. Output Voltage vs. Forward Input Current.

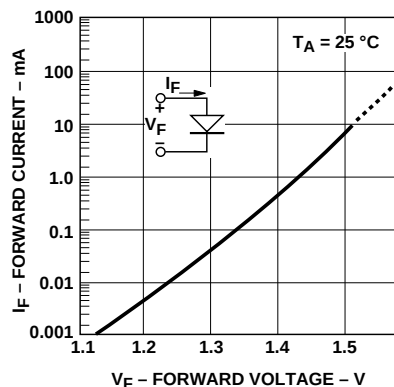


Figure 4. Typical Input Diode Forward Characteristic.

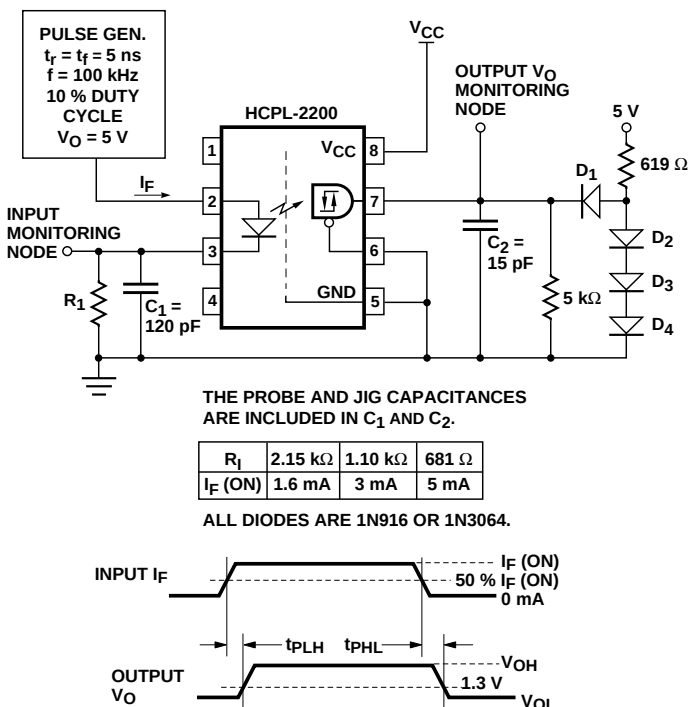
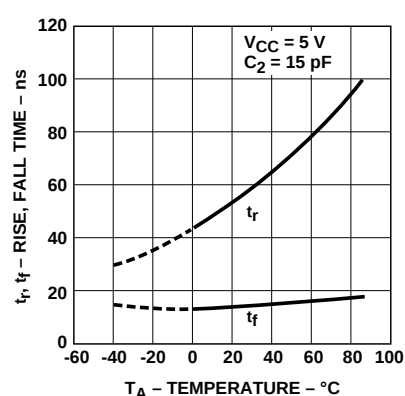
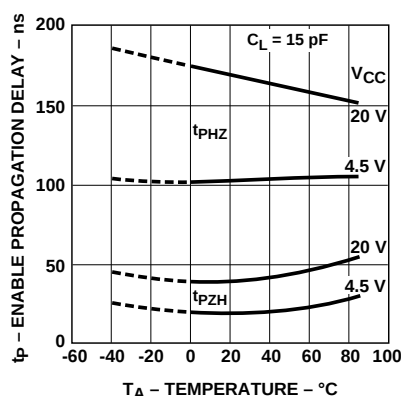
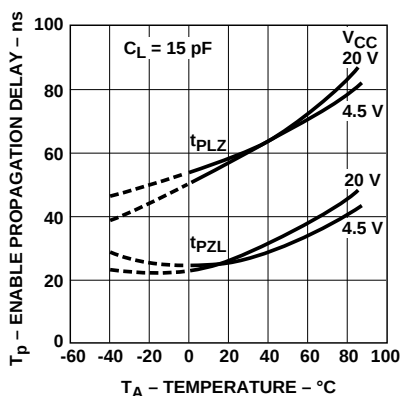
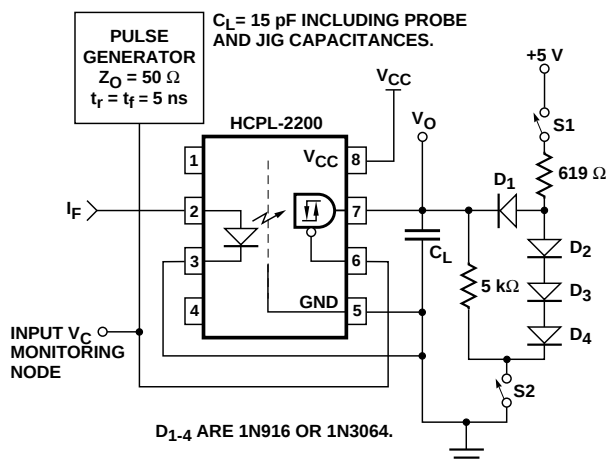
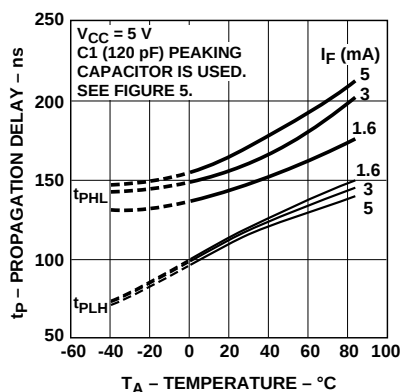


Figure 5. Test Circuit for t_{PLH} , t_{PHL} , t_r , and t_f .



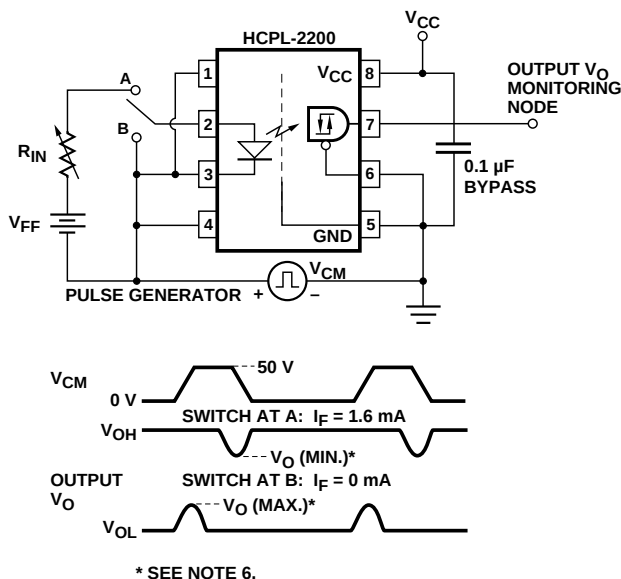


Figure 11. Test Circuit for Common Mode Transient Immunity and Typical Waveforms.

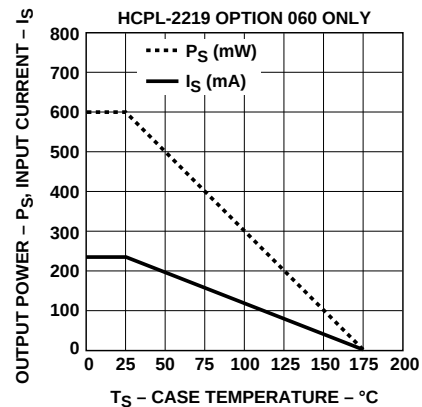


Figure 12. Thermal Derating Curve, Dependence of Safety Limiting Value with Case Temperature per VDE 0884.

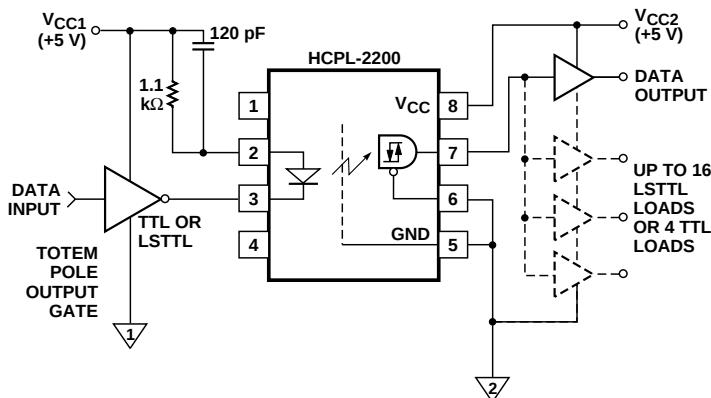


Figure 13. Recommended LSTTL to LSTTL Circuit.

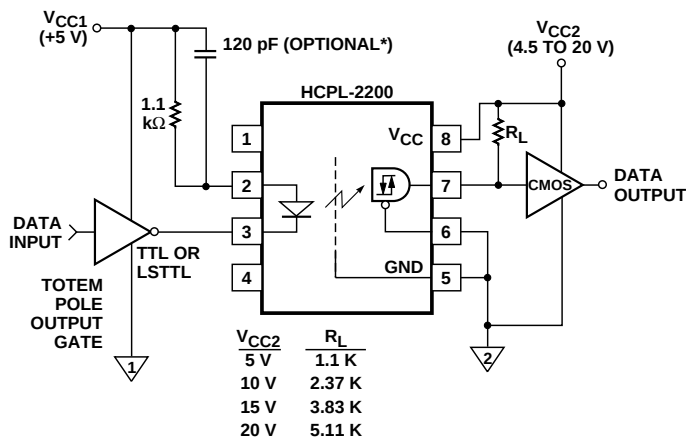


Figure 14. LSTTL to CMOS Interface Circuit.

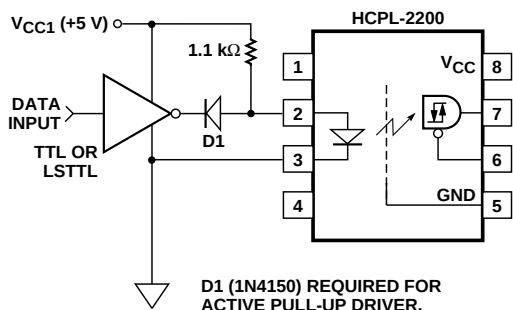


Figure 15. Recommended LED Drive Circuit.

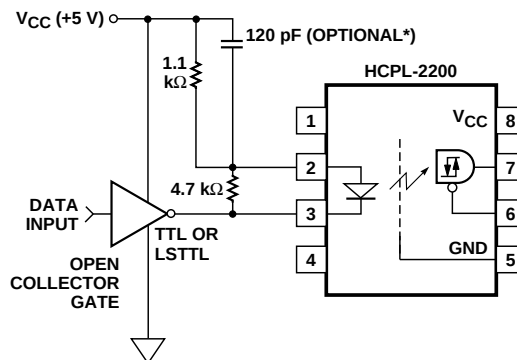


Figure 16. Series LED Drive with Open Collector Gate (4.7 kΩ Resistor Shunts I_{OH} from the LED).

*The 120 pF capacitor may be omitted in applications where 500 ns propagation delay is sufficient.